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Texas Instruments Enhanced Products Reliability Report

(Subject To Attached Disclaimers)

Device Type/Device Family: REF3220AMDBVREP Package Type: SOT-23 Wafer Fabrication Facility: TSMC Assembly/Test Facility: Carsem Compiled: 07/2012

Biased Life Test

Test Method: Test Condition: Sample Size: Rejects: Activation Energy (eV):	JESD22-A108 150°/500 hours or Equiv. 1831 0 .5
Activation Energy (eV):	.5
Equivalent Device Hours:	8E6
Failure Rate (FIT)*:	115

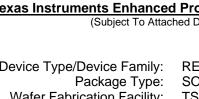
*Derated to +55°C with a 60% Confidence Level

Note: Data for EP product is specific to device technology and foundry. For this reason the FIT rate above may differ from Ti's external web page. This does not reflect a difference in quality but only a difference in sample size.

Package Related Tests

Description	Condition	Referenced Method	Sample Size/Rejects	
Biased Humidity or HAST	130°C / 85% / 250 hours	JESD22-A101 JESD22-A110	121/0	*
Autoclave	121 °C @ 2 atmospheres absolute for 96 hours	JESD22-A102	462/0	*
Temperature Cycle	-65 °C to +150 °C non-biased for 1000 cycles	JESD22-A104	462/0	*
High Temp Storage	170 °C / 420 hours	JESD22-A103-A	231/0	*

* Preconditioning per JEDEC Std. 22, Method A112/A113





Initial Product Qualification

The subject Enhanced Plastic device, device family, and/or package family have passed Texas Instruments product qualification as follows:

Description	Condition	Sample Size	Referenced Method
Electrical Characterization	TI Data Sheet	50 units/lot	N/A
Electrostatic Discharge Sensitivity	HBM MM	3 units/voltage	EIA/JESD22-A114 EIA/JESD22-A115
Latch-up	Per Technology	5/0 units/lot	EIA/JESD78
Physical Dimensions	TI Data Sheet	5/0	EIA/JESD22- B100
Thermal Impedance	Theta-JA on board	Per Pin-Package	EIA/JESD51
Bias Life Test	125°C / 1000 hours or equivalent	116/0	JESD22-A108 *
Biased Humidity	85°C / 85% / 1000 hours	77/0	JESD22-A101 *
HAST	or 130°C / 85% / 96 hours		JESD22-A110
Autoclave	121 °C @ 2 atmospheres absolute for 96 hours	77/0	JESD22-A102 *
Temperature Cycle	-65 °C to +150 °C non-biased for 1,000 cycles	77/0	JESD22-A104 *
Solder Heat	260 °C for 10 seconds	22/0	JESD22-B106
Resistance to Solvents	Ink symbol only	12/0	JESD22-B107
Solderability	Condition A (steam age for 8 hours)	22/0	ANSI/J-STD-002-92
Flammability	Method A / Method B	5/0	UL-1964
Bond Strength	-	76/0 wires	ASTM F-459
Die Shear	-	5/0	MIL-STD-883 Method 2019
High Temp Storage	150 °C / 1,000 hours	45/0	JESD22-A103-A *
Moisture Sensitivity	Surface Mount Only	12/0	J-STD-020-A * Precondition performed

Supplemental Device Characteristics

	Device Type:	REF3220AMDBVREP	
Die Revision:	C	Assembly Site:	Carsem
Master Die:	6ICC03299LWDS	Package Type:	DBV
Wafer Fab:	TSMC	Pin Count:	6
Fab Technology:	CMOS	Mold Compound:	Hitachi CEL9220
Fab Process:	.6-DPDM	Mount Compound:	Ablestik 8290(GRN)
Process Code:	N/A	Bond:	1.0 Au
Passivation:	Nitride	Lead Composition:	Cu
Metal 1:	Ti(0.4kA)/TiN(1kA)/AlCu(4kA)/ TiN(0.25kA)	Lead Finish:	NiPdAu
Metal 2:	TiN(1.5kA)/AlCu(8kA)/TiN(0.25kA)	Die Size:	58x32 Mils

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